

Application/Control No.	Applicant(s)/Patent und Reexamination	er
10/646,958	SMITH, CAREY W.	
Examiner	Art Unit	
Hong Cho	2616	

	SEARCHED				
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Class	Subclass	Date	Examiner		
370	352, 252, 389, 338, 328, 401,	4/4/2007	нс		
	419-421				
	469	1			
709	220-222	4/4/2007	нс		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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DATE	EXMR
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